

LH532000B

CMOS 2M (256K × 8/128K × 16) MROM

FEATURES

- 262,144 words × 8 bit organization
(Byte mode)
- 131,072 words × 16 bit organization
(Word mode)
- BYTE input pin selects bit configuration
- Access times: 120/150 ns (MAX.)
- Low-power consumption:
 - Operating: 275 mW (MAX.)
 - Standby: 550 μ W (MAX.)
- Programmable OE/OE and OE₁/OE₁/DC
- Static operation
- TTL compatible I/O
- Three-state outputs
- Single +5 V power supply
- Packages:
 - 40-pin, 600-mil DIP
 - 40-pin, 525-mil SOP
 - 48-pin, 12 × 18 mm² TSOP (Type I)
- ×16 word-wide pinout

PIN CONNECTIONS

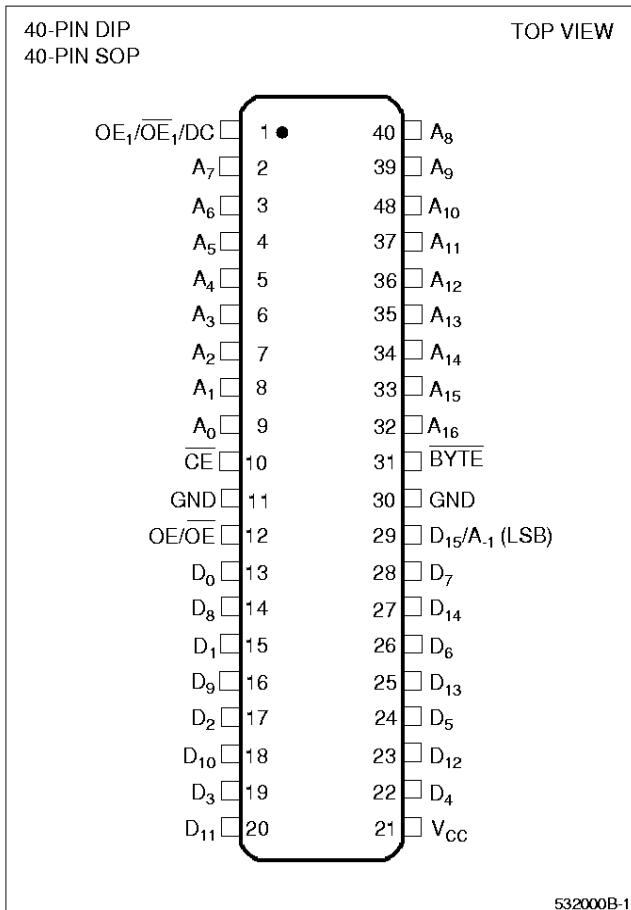


Figure 1. Pin Connections for DIP and SOP Packages

DESCRIPTION

The LH532000B is a 2M-bit mask-programmable ROM with two programmable memory organizations, byte and word modes. It is fabricated using silicon-gate CMOS process technology.

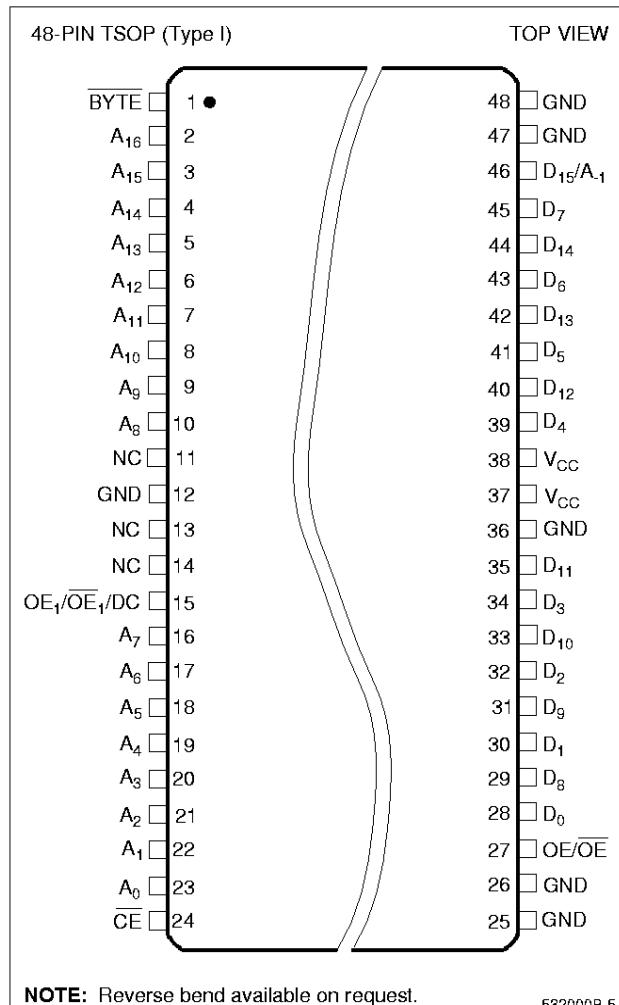


Figure 2. Pin Connections for TSOP Package

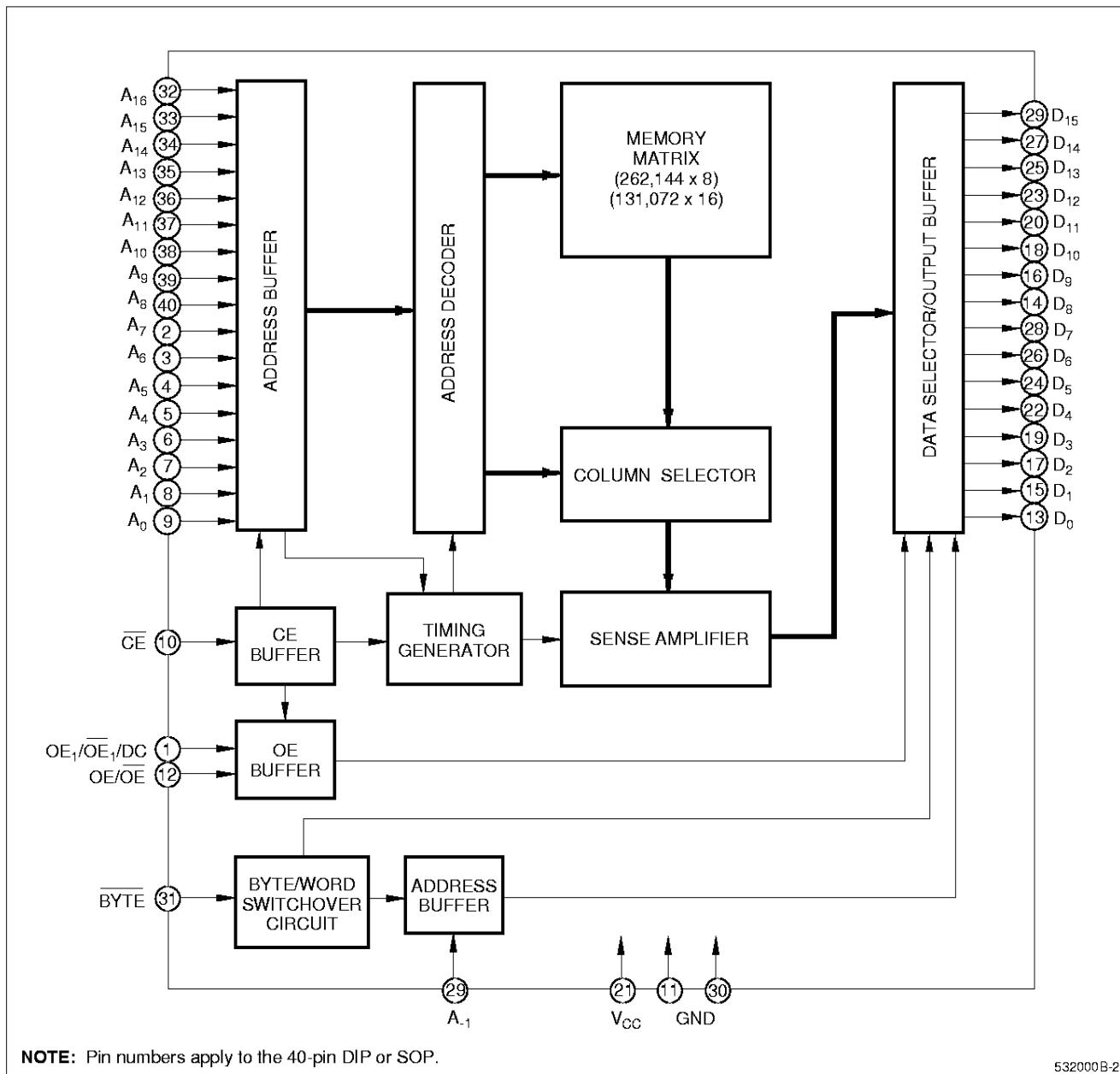


Figure 3. LH532000B Block Diagram

PIN DESCRIPTION

SIGNAL	PIN NAME	NOTE
A ₋₁	Address input (BYTE mode)	1
A ₀ - A ₁₆	Address input	
D ₀ - D ₁₅	Data output	1
CE	Chip enable input	
OE/OE	Output enable input	2

NOTES:

1. D₁₅/A₋₁ pin becomes LSB address input (A₋₁) when the bit configuration is set in byte mode, and data output (D₁₅) when in word mode. BYTE input pin selects bit configuration.
2. The active levels of OE/OE and OE₁/OE₁/DC are mask-programmable.
Selecting DC allows the outputs to be active for both high and low levels applied to this pin.
It is recommended to apply either a HIGH or a LOW to the DC pin.

SIGNAL	PIN NAME	NOTE
OE ₁ /OE ₁ /DC	Output enable input or Don't care	2
BYTE	Byte/word mode switch	
V _{CC}	Power supply (+5 V)	
GND	Ground	

TRUTH TABLE

\overline{CE}	OE/OE	OE_1/\overline{OE}_1	BYTE	A_{-1} (D₁₅)	DATA OUTPUT		ADDRESS INPUT		SUPPLY CURRENT
					D₀ – D₇	D₈ – D₁₅	LSB	MSB	
H	X	X	X	X	High-Z	High-Z	–	–	Standby (I _{SB})
L	L/H	X	X	X	High-Z	High-Z	–	–	Operating (I _{CC})
L	X	L/H	X	X	High-Z	High-Z	–	–	Operating (I _{CC})
L	H/L	H/L	H	Input inhibit	D ₀ – D ₇	D ₈ – D ₁₅	A ₀	A ₁₆	Operating (I _{CC})
L	H/L	H/L	L	L	D ₀ – D ₇	High-Z	A ₋₁	A ₁₆	Operating (I _{CC})
L	H/L	H/L	L	H	D ₈ – D ₁₅	High-Z	A ₋₁	A ₁₆	Operating (I _{CC})

NOTE:

1. X = H or L, High-Z = High-impedance.

ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	RATING	UNIT
Supply voltage	V _{CC}	–0.3 to +7.0	V
Input voltage	V _{IN}	–0.3 to V _{CC} + 0.3	V
Output voltage	V _{OUT}	–0.3 to V _{CC} + 0.3	V
Operating temperature	T _{OPR}	0 to +70	°C
Storage temperature	T _{STG}	–65 to +150	°C

RECOMMENDED OPERATING CONDITIONS (T_A = 0 to +70°C)

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT
Supply voltage	V _{CC}	4.5	5.0	5.5	V

DC CHARACTERISTICS (V_{CC} = 5 V ±10%, T_A = 0 to +70°C)

PARAMETER	SYMBOL	CONDITIONS	MIN.	TYP.	MAX.	UNIT	NOTE
Input 'Low' voltage	V _{IL}		–0.3		0.8	V	
Input 'High' voltage	V _{IH}		2.2		V _{CC} + 0.3	V	
Output 'Low' voltage	V _{OL}	I _{OL} = 2.0 mA			0.4	V	
Output 'High' voltage	V _{OH}	I _{OH} = –400 µA	2.4			V	
Input leakage current	I _{LI}	V _{IN} = 0 V to V _{CC}			10	µA	
Output leakage current	I _{LO}	V _{OUT} = 0 V to V _{CC}			10	µA	1
Operating current	I _{CC1}	t _{RC} = t _{RC} (MIN.)			50	mA	2
	I _{CC2}	t _{RC} = 1 µs			45		
	I _{CC3}	t _{RC} = t _{RC} (MIN.)			45	mA	3
	I _{CC4}	t _{RC} = 1 µs			40		
Standby current	I _{SB1}	$\overline{CE} = V_{IH}$			3	mA	
	I _{SB2}	$\overline{CE} = V_{CC} - 0.2$ V			100	µA	
Input capacitance	C _{IN}	f = 1 MHz			10	pF	
Output capacitance	C _{OUT}	T _A = 25°C			10	pF	

NOTES:

1. OE/OE₁ = V_{IL}, $\overline{CE}/OE/\overline{OE}_1$ = V_{IH}
2. V_{IN} = V_{IH} or V_{IL}, $\overline{CE} = V_{IL}$, outputs open
3. V_{IN} = (V_{CC} - 0.2 V) or 0.2 V, $\overline{CE} = 0.2$ V, outputs open

AC CHARACTERISTICS ($V_{CC} = 5 \text{ V} \pm 10\%$, $T_A = 0 \text{ to } +70^\circ\text{C}$)

PARAMETER	SYMBOL	120 ns		150 ns		UNIT	NOTE
		MIN.	MAX.	MIN.	MAX.		
Read cycle time	t_{RC}	120		150		ns	
Address access time	t_{AA}		120		150	ns	
Chip enable access time	t_{ACE}		120		150	ns	
Output enable delay time	t_{OE}		55		70	ns	
Output hold time	t_{OH}	5		10		ns	
CE to output in High-Z	t_{CHZ}		55		70	ns	1
OE to output in High-Z	t_{OHZ}		55		70	ns	

NOTE:

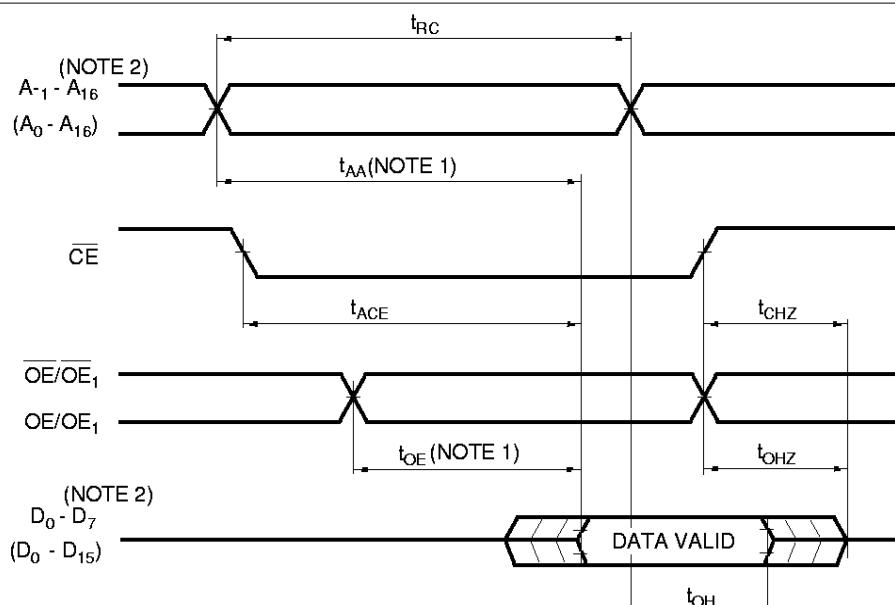
1. This is the time required for the output to become high-impedance.

AC TEST CONDITIONS

PARAMETER	RATING
Input voltage amplitude	0.6 V to 2.4 V
Input rise/fall time	10 ns
Input reference level	1.5 V
Output reference level	0.8 V and 2.2 V
Output load condition	1TTL +100 pF

CAUTION

To stabilize the power supply, it is recommended that a high-frequency bypass capacitor be connected between the V_{CC} pin and the GND pin.



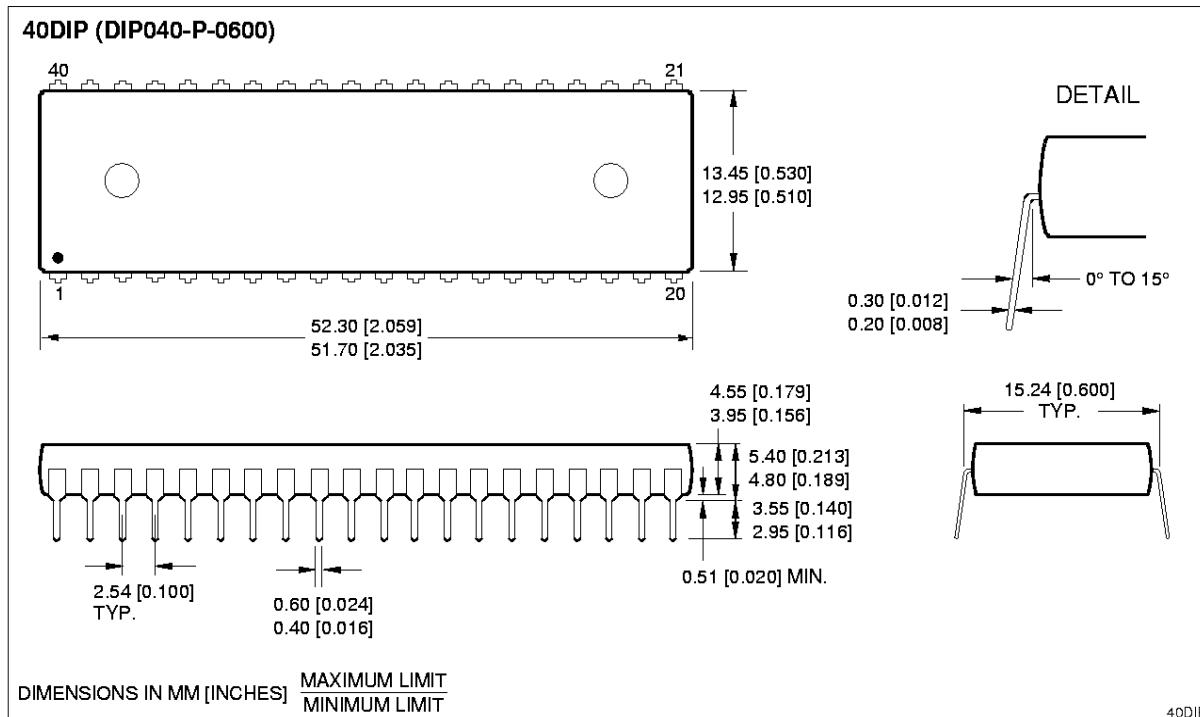
NOTES:

1. Data becomes valid after t_{AA} , t_{ACE} , and t_{OE} from address input, chip enable or output enable, respectively have been met.
2. Applied to byte mode. Signals in parentheses apply to word mode.

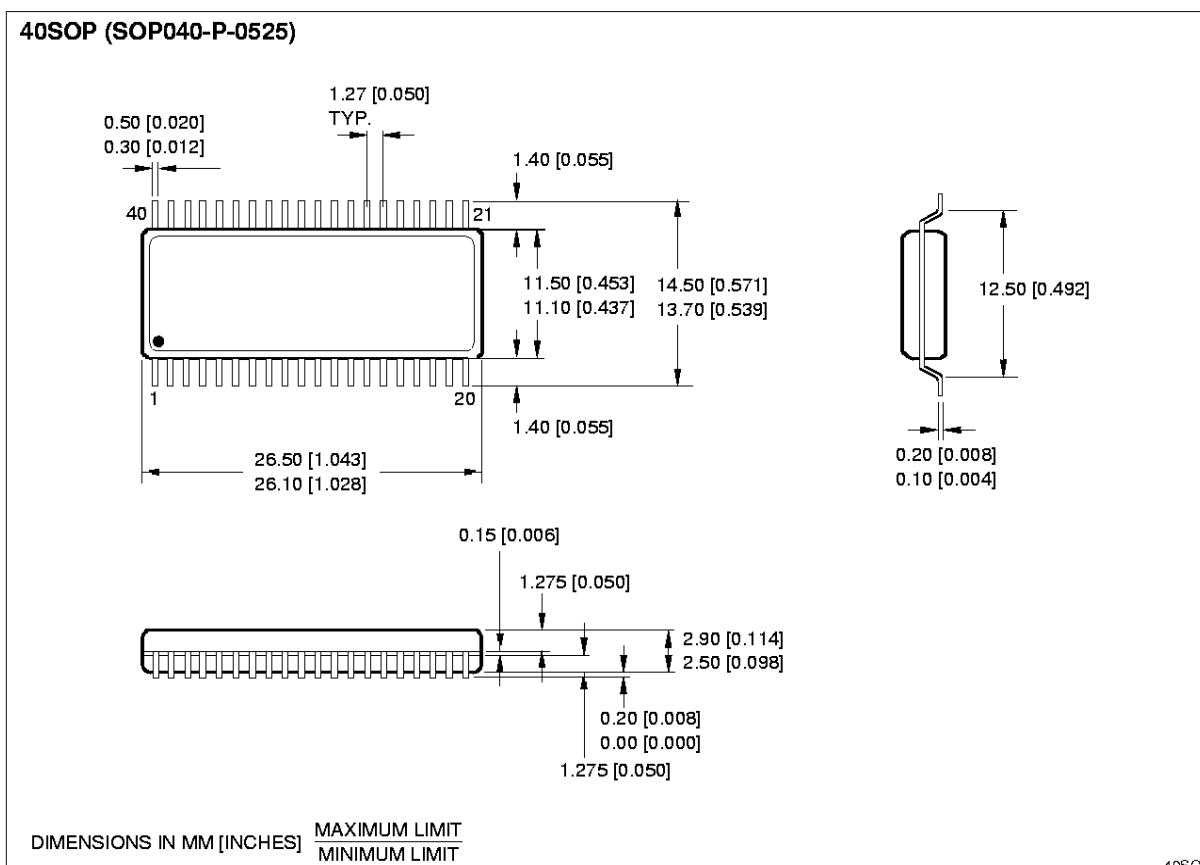
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Figure 4. Timing Diagram

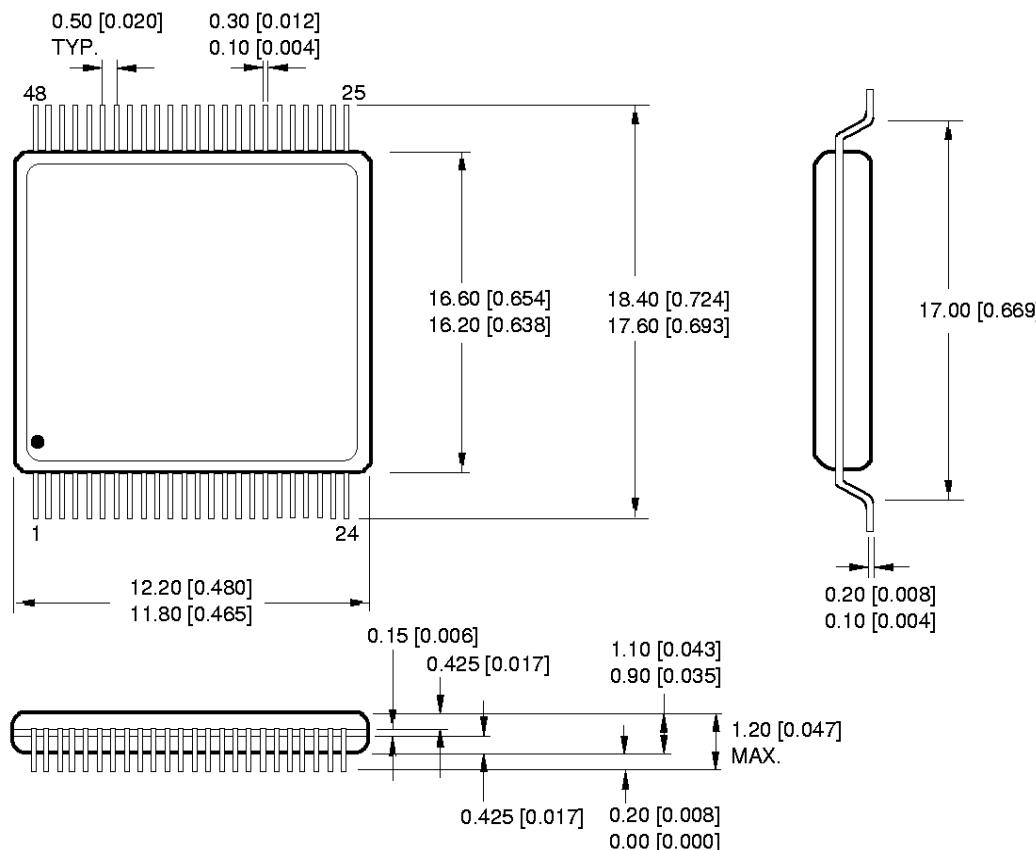
PACKAGE DIAGRAMS



40-pin, 600-mil DIP



40-pin, 525-mil SOP

48TSOP (TSOP048-P-1218)

DIMENSIONS IN MM [INCHES]

MAXIMUM LIMIT	MINIMUM LIMIT
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48TSOP

48-pin, 12 × 18 mm² TSOP (Type I)**ORDERING INFORMATION**LH532000B
Device TypeX
Package

- D 40-pin, 600-mil DIP (DIP040-P-0600)
- N 40-pin, 525-mil SOP (SOP040-P-0525)
- T 48-pin, 12 x 18 mm² TSOP (Type I) (TSOP048-P-1218)
- TR 48-pin, 12 x 18 mm² TSOP (Type I) Reverse bend (TSOP048-P-1218)

CMOS 2M (256K x 8 or 128K x 16) Mask Programmable ROM

Example: LH532000BD (CMOS 2M (256K x 8 or 128K x 16) Mask Programmable ROM, 40-pin, 600-mil DIP)

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